Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/822,357	CRANE ET AL.	
Examiner	Art Unit	
Chen-Wen Jiang	3744	

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Class	Subclass	Date	Examiner
62	175 115		
	126 204		
	228.4 228.		
	22.85		
	259.2		
	498		
417	3		
	53	5/17/2006	C1
Search	Updated	11/7/2006	C1

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Searched Inventor Searched	5/17/2006	cı		
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